Atty. Docket No. Serial No. Form B SUN-P4175 A THE STATE OF U.S. Department of Commerce 09/662,258 Patent and Trademark Office Applicant: Information Disclosure Statement by Applicant Judith E. Schwabe Filed: Group: (Use several sheets if necessary) September 14, 2000 2171 **U.S. Patent Documents** Class Document No. Date Name Subclass Filing Date Init. 04/11/2002 2002/0040936 Wentker et al. Α В 5,668,999 09/16/1997 Gosling AN 2 2 2004 $\overline{\mathsf{c}}$ 5,701,408 12/23/1997 Cornell et al. 5,761,510 06/02/1998 Smith, Jr. et al. D Technology Center 2100 05/02/2000 E 6,058,393 Meier et al. 05/23/2000 6,067,639 Rodrigues et al. Phópphol 07 96/18/2000 G 6,092,147 Levy et al. 05/08/2001 6,230,312 Hunt 08/07/2001 6,272,674 Holiday, Jr. 02/19/2002 6,349,344 Sauntry et al. 04/09/2002 6,370,686 Delo et al. K 07/09/2002 6,418,554 Delo et al. M 6,519,767 02/11/2003 Carter et al. 03/25/2003 Larsen et al. N 6.539.539 04/15/2003 6,549,930 Chrysos et al. Other Documents (Including Author, Title, Date, Pertinent Pages, etc.) Bergin et al., "Java Resources for Computer Science Instruction", Report of the ITICSE'98/ACTC'98 Working Group on Curricular Opportunities of Java Based Software Development, ITiCSE, pages 14-34 K Bowles et al., "A Comparison of Commercial Reliability Prediction Programs", Proceedings Annual Q Reliability and Maintainability Symposium, IEEE, pages 450-455 (1990) Cooper, Richard, "Persistent Languages Facilitate the Implementation of Software Version Management", IEEE, pages 56-65 (1989) Ferscha et al., "Java Based Conservative Distributed Simulation", Proceedings of the 1997 Winter Simulation Conference, pages 381-388 (1997) Foster et al., "A Security Architecture for Computational Grids", Fifth ACM Conference on Computer & Communications Security, pages 83-92 (1998) Lindsay et al., "A Generic Model for Fine Grained Configuration Management Including Version Control Bo and Traceability", Proceedings of the Australian Software Engineering Conference (ASWEC'97), IEEE Computer Society, pages 27-36 (1997) Examiner Date Considered

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Drawline through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.